



Silicon Carbide (SiC)	
<b>MOSFET</b> – EliteSiC,	
65 mohm, 1200 V, M3S	•
TO-247-3L	
NTHL070N120M3S	

#### **Features**

- Typ.  $R_{DS(on)} = 65 \text{ m}\Omega @ V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge  $(Q_{G(tot)} = 57 \text{ nC})$
- High Speed Switching with Low Capacitance (Coss = 57 pF)
- 100% Avalanche Tested
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb-Free 2LI (on second level interconnection)

# **Typical Applications**

- Solar Inverters
- Electric Vehicle Charging Stations
- UPS (Uninterruptible Power Supplies)
- Energy Storage Systems
- SMPS (Switch Mode Power Supplies)

# **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	1200	V
Gate-to-Source Voltage			$V_{GS}$	-10/+22	V
Continuous Drain Current (Notes 1, 3)	Stead	T <sub>C</sub> =25°C	I <sub>D</sub>	34	Α
Power Dissipation (Note 1)	State		P <sub>D</sub>	160	W
Continuous Drain Current (Notes 1, 3)	Stead	T <sub>C</sub> =100°C	I <sub>D</sub>	24	Α
Power Dissipation (Note 1)	State		P <sub>D</sub>	80	W
Pulsed Drain Current (Note 2)	T <sub>C</sub> = 25°C		I <sub>DM</sub>	98	Α
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C	
Source Current (Body Die $T_C = 25^{\circ}C$ , $V_{GS} = -3 \text{ V}$			I <sub>S</sub>	31	Α
Single Pulse Drain-to-So Energy (Note 4)	Source Avalanche		E <sub>AS</sub>	91	mJ
Maximum Lead Tempera (1/25" from case for 10 s		oldering	TL	270	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

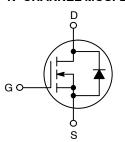
1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

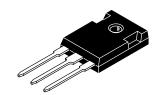
1

- 2. Repetitive rating, limited by max junction temperature.
- 3. The maximum current rating is based on typical  $R_{DS(on)}$  performance. 4. EAS of 91 mJ is based on starting  $T_J = 25^{\circ}C$ ; L = 1 mH,  $I_{AS} = 13.5$  A,  $V_{DD} = 100 \text{ V}, V_{GS} = 18 \text{ V}.$

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
1200 V	87 mΩ @ 18 V	34 A

### **N-CHANNEL MOSFET**





TO-247-3L CASE 340CX

## **MARKING DIAGRAM**



HL070N120M3S = Specific Device Code

= Assembly Location

Υ = Year

WW = Work Week = Lot Traceability

# **ORDERING INFORMATION**

Device	Package	Shipping
NTHL070N120M3S	TO-247-3L	30 Units / Tube

## **Table 1. THERMAL CHARACTERISTICS**

Parameter		Max	Unit
Junction-to-Case - Steady State (Note 1)		0.94	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	40	

# **Table 2. RECOMMENDED OPERATING CONDITIONS**

Parameter	Symbol	Value	Unit
Operation Values of Gate-to-Source Voltage	$V_{GSop}$	-53 +18	V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

**Table 3. ELECTRICAL CHARACTERISTICS** (T<sub>.1</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF-STATE CHARACTERISTICS	•			•	•		•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V, } I_{D} = 1 \text{ mA}$		1200	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 1 mA, reference (Note 6)		-	0.3	-	V/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1200 V	T <sub>J</sub> = 25°C	-	_	100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = +22/-10 \text{ V},$	V <sub>DS</sub> = 0 V	-	-	±1	μΑ
ON-STATE CHARACTERISTICS (Note	2)						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 7 mA	2.04	2.9	4.4	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 18 V, I <sub>D</sub> = 15	A, T <sub>J</sub> = 25°C	-	65	87	mΩ
		V <sub>GS</sub> = 18 V, I <sub>D</sub> = 15 A, T <sub>J</sub> = 175°C (Note 6)		-	136	-	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 15 A (Note 6)		-	12	-	S
CHARGES, CAPACITANCES & GATE F	RESISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 800 V		-	1230	_	pF
Output Capacitance	C <sub>OSS</sub>			-	57	_	1
Reverse Transfer Capacitance	C <sub>RSS</sub>			-	5	-	
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -3/18 \text{ V}, V_{DS} = 800 \text{ V},$		-	57	-	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	I <sub>D</sub> = 15 A	4	-	3.2	-	
Gate-to-Source Charge	Q <sub>GS</sub>			-	9.6	-	
Gate-to-Drain Charge	$Q_{GD}$			-	17	_	
Gate-Resistance	R <sub>G</sub>	f = 1 MHz		-	4.3	-	Ω
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -3/18 \text{ V}, V_{D}$	os = 800 V,	-	10	-	ns
Rise Time	t <sub>r</sub>	I <sub>D</sub> = 15 A, R <sub>G</sub> = 4.7 Ω Inductive load (Notes 5, 6)		-	24	_	
Turn-Off Delay Time	t <sub>d(OFF)</sub>			-	29	-	
Fall Time	t <sub>f</sub>			-	9.6	-	
Turn-On Switching Loss	E <sub>ON</sub>	7		-	254	-	μJ
Turn-Off Switching Loss	E <sub>OFF</sub>	7		-	46	-	
Total Switching Loss	E <sub>tot</sub>	7		_	300	-	]

Table 3. ELECTRICAL CHARACTERISTICS ( $T_J = 25^{\circ}C$  unless otherwise specified) (continued)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
SOURCE-DRAIN DIODE CHARACTERIST	rics	•			•	
Continuous Source-Drain Diode Forward Current	I <sub>SD</sub>	$V_{GS} = -3 \text{ V, } T_{C} = 25^{\circ}\text{C (Note 6)}$	-	_	31	А
Pulsed Source-Drain Diode Forward Current (Note 2)	I <sub>SDM</sub>	1	_	-	98	
Forward Diode Voltage	$V_{SD}$	$V_{GS} = -3 \text{ V}, I_{SD} = 15 \text{ A}, T_J = 25^{\circ}\text{C}$	-	4.7	-	V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = -3/18 \text{ V}, I_{SD} = 15 \text{ A},$	-	14	-	ns
Reverse Recovery Charge	$Q_{RR}$	dl <sub>S</sub> /dt = 1000 A/μs, V <sub>DS</sub> = 800 V (Note 6)	-	57	-	nC
Reverse Recovery Energy	E <sub>REC</sub>	7	-	3.1	-	μЈ
Peak Reverse Recovery Current	I <sub>RRM</sub>		-	8.2	-	Α
Charge Time	T <sub>A</sub>		_	7.7	_	ns
Discharge Time	T <sub>B</sub>	1	_	6.2	_	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. E<sub>ON</sub>/E<sub>OFF</sub> result is with body diode.

6. Defined by design, not subject to production test.

#### TYPICAL CHARACTERISTICS

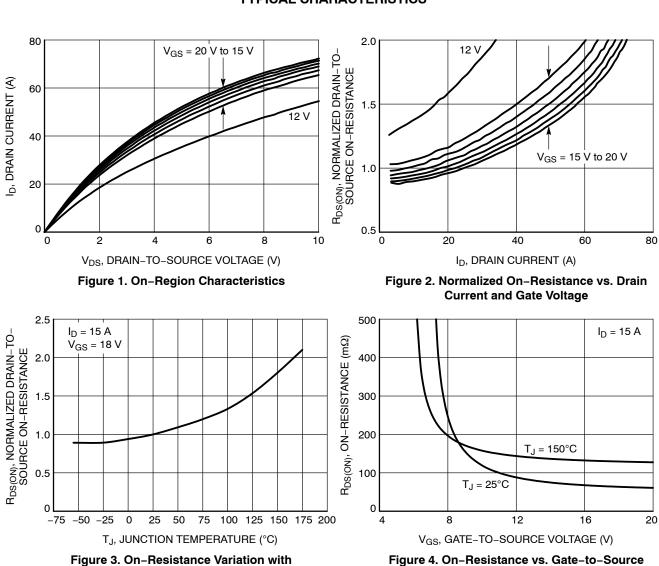


Figure 3. On–Resistance Variation with Temperature

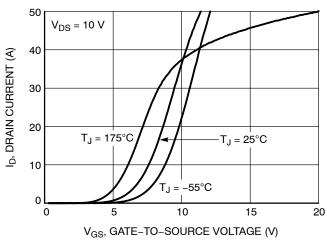


Figure 5. Transfer Characteristics

Figure 4. On–Hesistance vs. Gate–to–Source Voltage

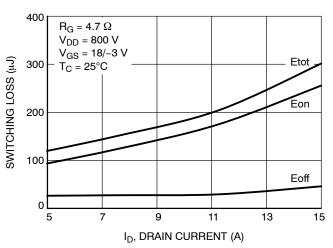


Figure 6. Switching Loss vs. Drain Current

## **TYPICAL CHARACTERISTICS**

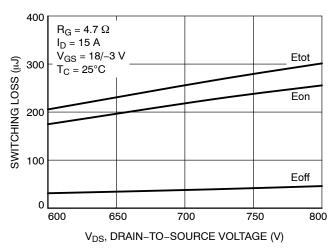


Figure 7. Switching Loss vs. Drain-to-Source Voltage

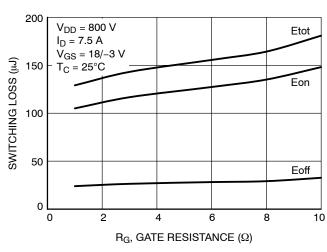


Figure 8. Switching Loss vs. Gate Resistance

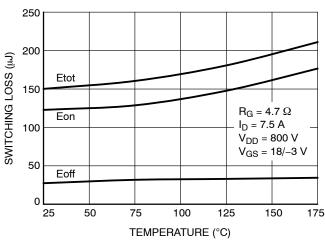


Figure 9. Switching Loss vs. Temperature

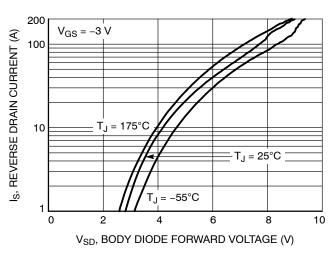


Figure 10. Reverse Drain Current vs. Body Diode Forward Voltage

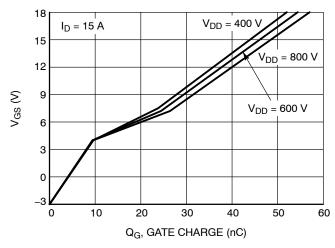


Figure 11. Gate-to-Source Voltage vs. Total Charge

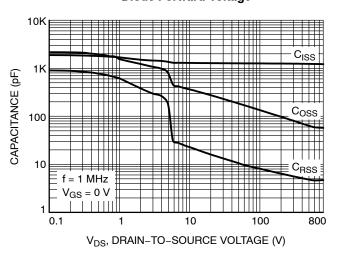


Figure 12. Capacitance vs. Drain-to-Source Voltage



## **TYPICAL CHARACTERISTICS**

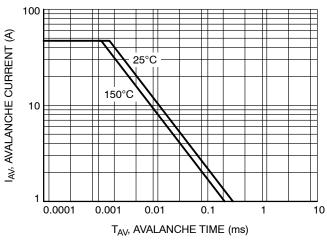


Figure 13. Unclamped Inductive Switching Capability

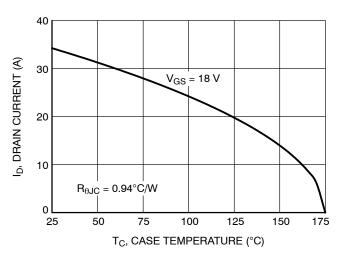


Figure 14. Maximum Continuous Drain Current vs. Case Temperature

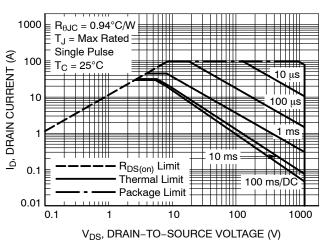


Figure 15. Safe Operating Area

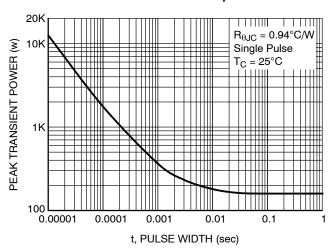


Figure 16. Single Pulse Maximum Power Dissipation

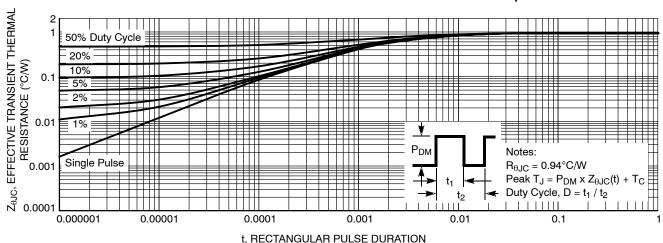
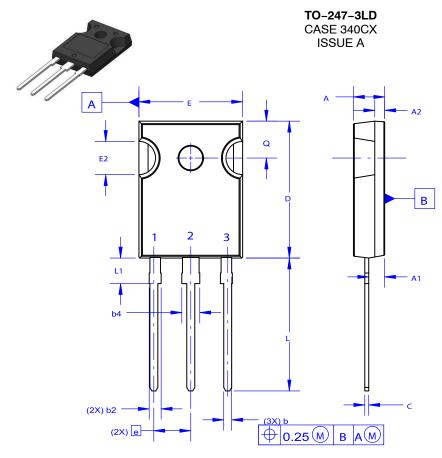


Figure 17. Junction-to-Case Transient Thermal Response

**DATE 06 JUL 2020** 





NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

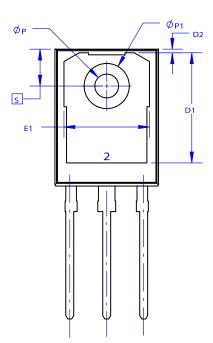
# GENERIC MARKING DIAGRAM\*



XXXXX = Specific Device Code A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.



DIM	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	4.58	4.70	4.82			
<b>A</b> 1	2.20	2.40	2.60			
A2	1.40	1.50	1.60			
D	20.32	20.57	20.82			
E	15.37	15.62	15.87			
E2	4.96	5.08	5.20			
е	~	5.56	~			
L	19.75	20.00	20.25			
L1	3.69	3.81	3.93			
ØΡ	3.51	3.58	3.65			
Q	5.34	5.46	5.58			
S	5.34	5.46	5.58			
b	1.17	1.26	1.35			
b2	1.53	1.65	1.77			
b4	2.42	2.54	2.66			
С	0.51	0.61	0.71			
D1	13.08	~	~			
D2	0.51	0.93	1.35			
E1	12.81	~	~			
ØP1	6.60	6.80	7.00			

DOCUMENT NUMBER:	98AON93302G	Electronic versions are uncontrolled except when accessed directly from the Document Reposit Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	TO-247-3LD		PAGE 1 OF 1	

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, Onsemi, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase

#### ADDITIONAL INFORMATION

**TECHNICAL PUBLICATIONS:** 

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$ 

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales